

**Search Notes**

Application/Control No.

10/553,081

Examiner

Laura M. Lee

Applicant(s)/Patent under  
Reexamination

HADTKE ET AL.

Art Unit

3724

**SEARCHED**

Class	Subclass	Date	Examiner
225	39,43, 44,45, 77	3/7/2007	LML
132	321, 325	3/7/2007	LML
206	63.5	3/7/2007	LML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search, Text Search, Considered IDS, Inventor Name Search	3/7/2007	LML